My Head Hurts, My Timing Stinks, and I Don't Love On-Chip Variation

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ABSTRACT

Abstract: Some ASIC vendors require designers to run static timing with on-chip variation analysis. For the uninitiated, this task can be both confusing and frustrating. This paper will show you:

- 1. Why on-chip variation analysis is important.
- 2. How to do on-chip variation analysis in Primetime.
- 3. How Primetime's on-chip variation analysis compares to Einstimer's linear combination of delays (LCD).
- 4. Why some ASIC vendors require on-chip variation analysis and some don't.



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1.0 Introduction

No two cells are the same. The same cell on two different chips could have dramatically different timing characteristics. That is why static timing sign-off is never complete until runs have been made with both the best-case and worst-case operating conditions. Additionally, two copies of the same cell on the same chip can have different timing characteristics. This on-chip variation is small compared to chip-to-chip variation. However, the effect still needs to be accounted for somewhere in static timing analysis. One method is to use the on-chip variation analysis feature of your static timing analysis tool.

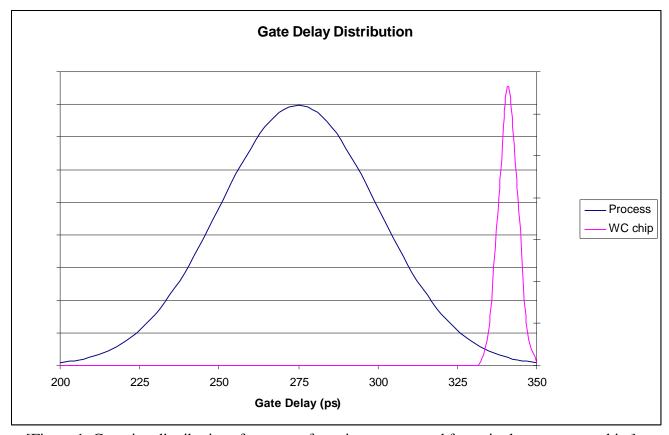
2.0 What is on-chip variation?

Constructing a cell on an ASIC is a process that involves many variables. Some of these variables are fairly consistent for the entire manufacturing process. Some variables vary from lot to lot but are consistent across a single lot of wafers. Still other variables vary from wafer to wafer but are consistent across a chip. Finally, some of the variations can occur within a single chip.

Examples of variables that can occur on a single chip include small variations in the mask, imperfections in optical proximity correction, and etch variations. Additionally, many of these variations can occur over a very small area. Consider for example a string of buffers that are all placed in a row. The gates in the middle of the string all have the same structures on each side, but the gates at the ends of the string are adjacent to different features that may cause different variations in the etching process.

The many variables involved in the manufacturing process mean the gate delay of a cell is really a Gaussian distribution with a mean and standard deviation determined by the cell design and these many variables. A randomly chosen instance of a cell on a randomly chosen chip could be running at any point within that Gaussian distribution [figure 1]. Fortunately, timing analysis does not need to directly verify the chip's operation at every point in the distribution. Instead, if a design is shown to work at both best case and worst case, it is assumed to work at any point in between.

The cells on a single chip, however, still have their own distribution as in figure 1. Ignoring this distribution by running only best case and worst case analysis can lead to problems which are discussed in the next section.

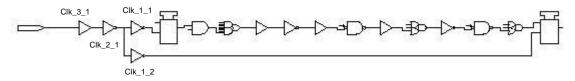


[Figure 1. Gaussian distributions for a manufacturing process and for a single, worst case chip.]

3.0 Problems that On-chip variation can cause

3.1 Setup Problems

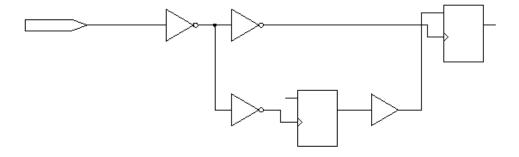
The circuit in figure 3 shows one of the critical paths on the chip. While the differences in loading of the clock drivers and parasitics of the clock nets will be included in calculating the clock arrival times at the flops, the on-chip variation effects are not being considered when doing a worst-case only analysis. If the clock path clock driver ends up being slightly faster than the data path clock driver, there is a potential of manufacturing chips which have setup violations that your static timing analysis didn't tell you about.



[Figure 2. Critical path used in setup examples]

3.2 Hold Problems

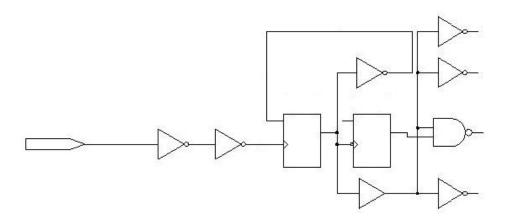
In the circuit in figure 3, we have a very short logic path between two flops. Again, a worst-case or best-case only analysis will consider loading and parasitics of the clock tree, but the on-chip variation effects will not be modeled. If the data path clock driver ends up being slightly faster than the clock path clock driver, there is a potential of manufacturing chips which have hold violations that your static timing analysis didn't tell you about.



[Figure 3. Short path used in hold examples]

3.3 Clock Gating

The circuit in figure 4 is a clock gating circuit. It starts with a clock divider register. The clock tree fanning out from there starts with a single clock buffer in the first level. The second level of the clock tree has four clock drivers, one of which is a NAND gate performing a clock gating function. To prevent glitches or pulse shrinkage caused by the clock gate, the gating input of the NAND should only change when the clock input to the NAND is low. This is best accomplished by using a negative edge triggered flip flop for the gating register. If the stage 1 clock driver and the gating register are both modeled with worst case delays, but the clock to Q time of the gating register ends up being a little bit faster, you have the potential for shortening the clock when you enter power down mode and glitching the clock when you exit power down mode.



[Figure 4. Circuit used in clock gating examples]

4.0 Timing without On-Chip variation

Startpoint: tx_ll/ct_arb/ct_man/mbst_rlt_1

The appendices include the timing scripts that were used to constrain the chip for the examples here. First let's look at how the worst case path looks before we turn on on-chip variation analysis. We have included the –path_type full_clock option to the report timing command so we can watch what happens to the clock tree delays when OCV analysis gets turned on.

> report_timing -nosplit -input_pins -to [get_pins "\$max_pin \$clkgate_pin"] -path_type full_clock

```
(rising edge-triggered flip-flop clocked by clk_core)
 Endpoint: tx_ll/ct_arb/ct_man/ct_ay_rg_43_4
                        (rising edge-triggered flip-flop clocked by clk_core)
 Path Group: clk core
 Path Type: max
 Point
                                                                                                                                    Incr Path

      clock clk_core (rise edge)
      0.00
      0.00

      clock source latency
      0.00
      0.00

      clk_core (in)
      0.00
      0.00

      clk_core_box_3_1/A (CLK_Q)
      0.00
      0.00

      clk_core_box_3_1/Z (CLK_Q)
      0.17 + 0.17 r

      clk_core_box_2_6/A (CLKI_O)
      0.11 * 0.29 r

      clk_core_box_2_6/Z (CLKI_O)
      0.26 + 0.54 f

      clk_core_box_1_69/A (CLKI_O)
      0.07 * 0.62 f

      clk_core_box_1_69/Z (CLKI_O)
      0.18 + 0.80 r

      tx_ll/ct_arb/ct_man/mbst_rlt_1/L2 (D_F_LPH0001_LPC_E)
      0.01 * 0.81 r

      tx_ll/ct_arb/ct_man/mbst_rlt_1/L2 (D_F_LPH0001_LPC_E)
      0.41 1.22 f

      tx_ll/ct_arb/ct_man/Ull37/A (AND2_E)
      0.01 1.23 f

 .....Data path removed from report
 4.17
 data arrival time

      clock clk_core (rise edge)
      3.76

      clock source latency
      0.00

      clk_core (in)
      0.00

      clk_core_box_3_1/A (CLK_Q)
      0.00

      clk_core_box_3_1/Z (CLK_Q)
      0.17 + 3.93 r

      clk_core_box_2_6/A (CLKI_O)
      0.11 * 4.05 r

      clk_core_box_2_6/Z (CLKI_O)
      0.26 + 4.30 f

      clk_core_box_1_101/A (CLKI_O)
      0.07 * 4.38 f

      clk_core_box_1_101/Z (CLKI_O)
      0.18 + 4.56 r

      tx_11/ct_arb/ct_man/ct_ay_rg_43_4/E (D_F_LPH0002_LPC_E)
      0.01 * 4.57 r

      clock uncertainty
      -0.10
      4.47

      library setup time
      -0.23
      4.24

                                                                                                                                  -0.23
                                                                                                                                                             4.24
 library setup time
data required time
                                                                                                                                                             4.24
 _____
 data required time
 data arrival time
   ._____
 slack (MET)
                                                                                                                                                              0.07
```

The clock tree in this section of the chip happens to be perfectly balanced such that the clock arrival time at the startpoint register is the same as the clock arrival time at the endpoint register. The clock uncertainty is set to 100 ps to model PLL jitter. For the moment it looks like timing is great, but we haven't accounted for the possibility that, although clk_core_box_1_69 and clk_core_box_1_101 are both modeled with worst case timing, in reality they may have slightly different propagation delays. The clock nets that are not common to both paths may also introduce some variability.

The tests on our short path and clock_gating hold check show similarly encouraging results.

```
> report_timing -nosplit -input_pins -delay min -to [get_pins "$min_pin
$clkgate_pin"] -path_type full_clock
Startpoint: tx_py/py_stat/o_tstat0
             (rising edge-triggered flip-flop clocked by xi_tsclk)
 Endpoint: tx_ll/basic/stat_ck/tstat_reg_0
           (rising edge-triggered flip-flop clocked by xi_tsclk)
 Path Group: xi_tsclk
 Path Type: min
 Point
  ______
                                                         0.00 0.00
 clock xi_tsclk (rise edge)
                                                         0.00 0.00

0.00 0.00 r

0.00 0.00 r

0.24 + 0.24 f

0.16 * 0.40 f

0.26 + 0.66 r

0.06 * 0.72 r
 clock source latency
 xi_tsclk (in)
 xi_tsclk_box_2_1/A (CLKI_Q)
 xi_tsclk_box_2_1/Z (CLKI_Q)
 xi_tsclk_box_1_10/A (CLKI_O)
 xi_tsclk_box_1_10/Z (CLKI_0)
 tx_py/py_stat/o_tstat0/E (D_F_LPH0001_H)
                                                         0.14
                                                                    0.85 f
 tx_py/py_stat/o_tstat0/L2 (D_F_LPH0001_H)
                                                         0.00
                                                                    0.85 f
 tx_ll/basic/stat_ck/U371/A (BUFFER_F)
 tx_ll/basic/stat_ck/tstat_reg_0/D (D_F_LPH0001_LPC_E) 0.00 data arrival time
                                                                    0.94 f
                                                                   0.95 f
                                                                     0.95
                                                          0.00 0.00
0.00 0.00
0.00 0.00 r
 clock xi_tsclk (rise edge)
 clock source latency
                                                          0.00
 U.00 r
0.00 0.00 r
0.24 + 0.24 f
0.24 f
0.16 * 0.40 f
0.25 + 0.66 r
0.26 + 0.66 r
0.27 clock uncertainty
0.10 0.10 0.81

tx_ll/basic/stat_ck/tstat_reg_0/E (D_F_LPH0001_LPC_E)
1ibrary hold time
data required time
 xi_tsclk (in)
 ______
 data required time
 data arrival time
 ______
```

slack (MET)

0.17

Startpoint: clk_rst_400/enable_clk_2nd_divby2_reg/E

(internal path startpoint clocked by clk_200)

Endpoint: clk_200_box_2_4

(rising clock gating-check end-point clocked by clk 200)

Path Group: **clock_gating_default**

Path Type: min

Point	Incr	Path
<pre>clock clk_200 (fall edge) clock source latency clk_rst_400/clk_2nd_divby2_reg/L2 (D_LDR0001_E) clk_rst_400/enable_clk_2nd_divby2_reg/E (D_LDF0001_E) input external delay clk_rst_400/enable_clk_2nd_divby2_reg/L2 (D_LDF0001_E) clk_200_box_2_4/B (NAND2_O) data arrival time</pre>	2.50 0.72 0.00 0.00 0.00 0.41 0.00	2.50 3.22 3.22 f 3.23 f 3.23 f 3.63 r 3.63 r 3.63
<pre>clock clk_200 (fall edge) clock source latency clk_rst_400/clk_2nd_divby2_reg/L2 (D_LDR0001_E) clk_200_box_3_1/A (CLK_Q) clk_200_box_3_1/Z (CLK_Q) clk_200_box_2_4/A (NAND2_O) clk_200_box_2_4/A (NAND2_O) clock gating hold time data required time</pre>	2.50 0.72 0.00 0.00 0.20 + 0.06 *	3.42 f
data required time data arrival time		3.49 -3.63
slack (MET)		0.14

5.0 How to Model On-Chip Variation in Primetime

To do on-chip variation analysis, every timing arc in the design must have both a minimum and a maximum delay which account for the on-chip variation. These are not the same delays that you would use for a simple min-max analysis. Those delays represent the minimum and maximum delays that will be seen across all chips from that process. For on-chip variation analysis, we want the minimum and maximum delays that could be seen across a single chip. For on-chip variation analysis we will make two analysis runs. The "slow-chip" analysis will set the maximum delays at the worst case delays for the process and the minimum delays slightly faster than that. For the "fast-chip" analysis, we will set the minimum delays to the best case delays for the process, and we will set the maximum delays slightly slower than the best case delays.

Primetime has several methods for specifying these delays.

5.1 Annotate from one SDF file

If you are back-annotating delays from an SDF file, Primetime can get the delay values from the min and max of the SDF triplet.

read_sdf -analysis_type on_chip_variation foo.sdf

5.2 Annotate from two SDF files

Another choice is to read the data from two SDF files.

```
read_sdf -analysis_type on_chip_variation -min_file foo_min.sdf \
    -max file foo max.sdf
```

5.4 Two Operating conditions

Sometimes you may have operating conditions specifically scaled for use with on-chip variation analysis. For a slow chip analysis, the worst case operating condition is specified with –max and the scaled worst case operating condition is specified with –min. For a fast chip analysis, the best case operating condition is specified with –min and the scaled best case operating condition is specified with –max.

```
set_operating_conditions -analysis_type on_chip_variation -min $WCOCV -max $WC
```

5.4 Single Operating condition

On-chip variation analysis can still be run even if you have only one operating condition. In this case the minimum and maximum times are simply scaled versions of the delays determined from the single operating condition that is loaded. The scaling factors are set by the set_timing_derate command described next. This is the method that was used for this paper.

```
set_operating_conditions -analysis_type on_chip_variation $OP_CON
set_timing_derate -min 0.8 -max 1.0
```

5.5 Set_timing_derate

The set_timing_derate command can be used with any of the above methods to provide further scaling of the timing paths. Scaling factors can be set independently for data paths, clock paths, cell delays, net delays, and cell timing checks. If neither –clock nor -data is specified, the derating factors apply to both clock and data paths. If –cell_delay, -net_delay, and –cell_check are all omitted from the command, the derating factors apply to both cell and net delays, but not to cell timing checks such as setup and hold times.

For example the following commands could be used to do a fast chip analysis with the best case operating condition loaded, ten percent variation in cell delays, five percent variation in net delays, and a five percent variation in cell timing checks.

```
set_operating_conditions -analysis_type on_chip_variation $BC_OP_CON
set_timing_derate -min 1.0 -max 1.10 -cell_delay
set_timing_derate -min 1.0 -max 1.05 -net_delay
set_timing_derate -min 1.0 -max 1.05 -cell_check
```

6.0 My Timing Stinks!!

After two simple commands to turn on on-chip variation analysis, we find out that our timing stinks and we don't love on chip variation analysis.

```
set_operating_conditions -analysis_type on_chip_variation set_timing_derate -min 0.8 -max 1.0
```

Here we are telling Primetime to assume that the min paths can be twenty percent faster than the max paths. That's a lot. More typically on-chip variation is modeled at six or eight or maybe ten percent. Your ASIC or library vendor should tell you what is appropriate for the library that you are using.

6.1 Setup Problems

When doing a setup test, the timing tool wants to verify that the latest possible data arrival can still be captured by the earliest possible clock arrival at the endpoint register. The latest possible data arrival is determined by taking the maximum delays along the clock path to the startpoint register and the maximum delays along the slowest data path from the startpoint register to the endpoint register. The earliest possible clock arrival at the endpoint register is determined by taking the minimum delays along the clock path to the endpoint register.

Our long timing path, which previously had seventy picoseconds of positive slack, is now failing by ninety picoseconds.

Point	Incr	Path
clock clk core (rise edge)	0.00	0.00
clock source latency	0.00	0.00
clk_core (in)	0.00	0.00 r
clk_core_box_3_1/A (CLK_Q)	0.00	0.00 r
clk_core_box_3_1/Z (CLK_Q)	0.17 +	0.17 r
clk_core_box_2_6/A (CLKI_O)	0.11 *	0.29 r
clk_core_box_2_6/Z (CLKI_O)	0.26 +	0.54 f
clk_core_box_1_69/A (CLKI_O)	0.07 *	0.62 f
clk_core_box_1_69/Z (CLKI_O)	0.18 +	0.80 r
<pre>tx_ll/ct_arb/ct_man/mbst_rlt_1/E (D_F_LPH0001_LPC_E)</pre>	0.01 *	0.81 r
tx_ll/ct_arb/ct_man/mbst_rlt_1/L2 (D_F_LPH0001_LPC_E)	0.41	1.22 f
tx_ll/ct_arb/ct_man/U1137/A (AND2_E)	0.01	1.23 f
Data path removed from report		
tx ll/ct arb/ct man/U4921/Z (OA21 H)	0.14	4.17 f
<pre>tx_ll/ct_arb/ct_man/ct_ay_rg_43_4/D (D_F_LPH0002_LPC_E) data arrival time</pre>	0.00	4.17 f 4.17

```
3.76
0.00 3.76
clock clk_core (rise edge)
clock source latency
clk core (in)
                                                      0.00
                                                               3.76 r
clk core box 3 1/A (CLK O)
                                                      0.00
                                                                3.76 r
                                                              3.90 r
clk core box 3 1/Z (CLK Q)
                                                      0.14 +
                                                      0.09 *
clk_core_box_2_6/A (CLKI_O)
                                                               3.99 r
clk_core_box_2_6/Z (CLKI_0)
                                                               4.20 f
                                                      0.21 +
                                                     0.06 *
clk_core_box_1_101/A (CLKI_O)
                                                               4.25 f
                                                     0.14 +
                                                               4.40 r
clk core box 1 101/Z (CLKI O)
tx_ll/ct_arb/ct_man/ct_ay_rg_43_4/E (D_F_LPH0002_LPC_E) 0.01 *
                                                               4.41 r
                                                     -0.10
                                                                4.31
clock uncertainty
library setup time
                                                     -0.23
                                                                4.08
data required time
                                                                4.08
data required time
                                                                4.08
data arrival time
                                                                -4.17
slack (VIOLATED)
                                                                -0.09
```

The path that is timed with maximum delays, the data path, shows the same timing as before. However, the clock latency to the endpoint register, using minimum delays, is now 160 ps faster than before.

6.2 Hold Problems

When doing a hold test, the timing tool wants to verify that the earliest possible data arrival does not arrive at the endpoint register before the latest possible clock arrival. So we use min delays for the clock path to the startpoint register, min delays through the shortest data path, and max delays for the clock path to the endpoint register.

Here again, a previously passing timing check has now started to fail.

Point	Incr	Path
clock xi_tsclk (rise edge)	0.00	0.00
clock source latency	0.00	0.00
xi_tsclk (in)	0.00	0.00 r
xi_tsclk_box_2_1/A (CLKI_Q)	0.00	0.00 r
xi_tsclk_box_2_1/Z (CLKI_Q)	0.19 +	0.19 f
xi_tsclk_box_1_10/A (CLKI_O)	0.13 *	0.32 f
xi_tsclk_box_1_10/Z (CLKI_0)	0.21 +	0.53 r
<pre>tx_py/py_stat/o_tstat0/E (D_F_LPH0001_H)</pre>	0.04 *	0.57 r
tx_py/py_stat/o_tstat0/L2 (D_F_LPH0001_H)	0.11	0.68 f
tx_ll/basic/stat_ck/U371/A (BUFFER_F)	0.00	0.68 f
<pre>tx_ll/basic/stat_ck/U371/Z (BUFFER_F)</pre>	0.07	0.76 f
<pre>tx_ll/basic/stat_ck/tstat_reg_0/D (D_F_LPH0001_LPC_E)</pre>	0.00	0.76 f
data arrival time		0.76

<pre>clock xi_tsclk (rise edge)</pre>	0.00	0.00
clock source latency	0.00	0.00
xi_tsclk (in)	0.00	0.00 r
xi_tsclk_box_2_1/A (CLKI_Q)	0.00	0.00 r
xi_tsclk_box_2_1/Z (CLKI_Q)	0.24 +	0.24 f
xi_tsclk_box_1_8/A (CLKI_O)	0.16 *	0.40 f
xi_tsclk_box_1_8/Z (CLKI_O)	0.26 +	0.66 r
<pre>tx_ll/basic/stat_ck/tstat_reg_0/E (D_F_LPH0001_LPC_E)</pre>	0.06 *	0.71 r
clock uncertainty	0.10	0.81
<pre>tx_ll/basic/stat_ck/tstat_reg_0/E (D_F_LPH0001_LPC_E)</pre>		0.81 r
library hold time	-0.03	0.78
data required time		0.78
data required time		0.78
data arrival time		-0.76
slack (VIOLATED)		-0.02

As expected, the clock pin at the endpoint register has the same arrival time as it did before, but the data path is now 190ps faster.

6.3 Clock Gating Problems

With an AND gate, we want to verify that the gating signal can only change while the clock is low. A hold check is done to verify that the gating signal changes after the falling edge of the clock, and a setup check is done to verify that the gating signal changes before the next rising edge of the clock. We're not looking at the setup check here because it has lots of positive slack and is therefore not very interesting. The hold check is going to use min delays along the gating path and max delays along the clock path.

Point	Incr	Path
clock clk_200 (fall edge) clock source latency clk_rst_400/clk_2nd_divby2_reg/L2 (D_LDR0001_E) clk_rst_400/enable_clk_2nd_divby2_reg/E (D_LDF0001_E) input external delay clk_rst_400/enable_clk_2nd_divby2_reg/L2 (D_LDF0001_E) clk_200_box_2_4/B (NAND2_0) data arrival time	2.50 0.58 0.00 0.00 0.00 0.33 0.00	2.50 3.08 3.08 f 3.08 f 3.08 f 3.41 r 3.41 r
<pre>clock clk_200 (fall edge) clock source latency clk_rst_400/clk_2nd_divby2_reg/L2 (D_LDR0001_E) clk_200_box_3_1/A (CLK_Q) clk_200_box_3_1/Z (CLK_Q) clk_200_box_2_4/A (NAND2_O) clk_200_box_2_4/A (NAND2_O) clock gating hold time</pre>	2.50 0.72 0.00 0.00 0.20 + 0.06 *	2.50 3.22 3.22 f 3.22 f 3.42 f 3.49 f 3.49 f 3.49

data required time	3.49
data required time data arrival time	3.49 -3.41
slack (VIOLATED)	-0.08

7.0 What is Clock Reconvergence Pessimism Removal?

Taking a careful look at the timing reports above, we can see that we are being unfairly punished. For example, in the setup case, clock driver clk_core_box_3_1 is in both the data path and the clock path. In the data path it is given a propagation time of 170ps, while in the clock path it is given a propagation time of 140ps. While the propagation delay of that cell could be either 140ps or 170ps, it can't be both! If the propagation delay for an edge on its way to the data path was 170ps, then it was also 170ps on its way to the clock path. To assume differently is overly pessimistic.

Primetime is able to correct this problem through an algorithm called clock reconvergence pessimism removal (CRPR). To enable CRPR, simply set the appropriate variable.

```
set timing_remove_clock_reconvergence_pessimism true
```

Startpoint: tx_ll/ct_arb/ct_man/mbst_rlt_1

Lets' see what it does to our failing setup test:

```
(rising edge-triggered flip-flop clocked by clk_core)
  Endpoint: tx_ll/ct_arb/ct_man/ct_ay_rg_43_4
            (rising edge-triggered flip-flop clocked by clk_core)
  Path Group: clk_core
  Path Type: max
  Min Clock Paths Derating Factor: 0.80
                                                               Incr Path
  Point
                                                               0.00
0.00 0.00
  clock clk core (rise edge)
  clock source latency
                                                                          0.00 r
                                                                0.00
  clk_core (in)
  clk_core_box_3_1/A (CLK_Q)
                                                                0.00
                                                                           0.00 r
                                                               0.17 + 0.11 *
  clk_core_box_3_1/Z (CLK_Q)
                                                                           0.17 r
  clk_core_box_2_6/A (CLKI_0)
                                                                            0.29 r
  clk_core_box_2_6/Z (CLKI_O)
                                                                0.26 +
                                                                            0.54 f
  clk_core_box_1_69/A (CLKI_0)
                                                               0.07 *
                                                                            0.62 f
  clk_core_box_1_69/Z (CLKI_O)
                                                               0.18 +
                                                                           0.80 r
 tx_ll/ct_arb/ct_man/mbst_rlt_1/E (D_F_LPH0001_LPC_E) 0.01 *
tx_ll/ct_arb/ct_man/mbst_rlt_1/L2 (D_F_LPH0001_LPC_E) 0.41
tx_ll/ct_arb/ct_man/U1137/A (AND2_E) 0.01
                                                                            0.81 r
                                                                            1.22 f
                                                                            1.23 f
.....Data path removed from report
  tx_ll/ct_arb/ct_man/U4921/Z (OA21_H)
                                                                0.14
                                                                           4.17 f
  tx_ll/ct_arb/ct_man/ct_ay_rg_43_4/D (D_F_LPH0002_LPC_E) 0.00
                                                                           4.17 f
  data arrival time
                                                                            4.17
                                                                3.76
0.00
  clock clk_core (rise edge)
                                                                            3.76
                                                                            3.76
  clock source latency
```

clk_core (in)	0.00	3.76 r	
clk_core_box_3_1/A (CLK_Q)	0.00	3.76 r	
clk_core_box_3_1/Z (CLK_Q)	0.14 +	3.90 r	
clk_core_box_2_6/A (CLKI_O)	0.09 *	3.99 r	
clk_core_box_2_6/Z (CLKI_O)	0.21 +	4.20 f	
clk_core_box_1_101/A (CLKI_O)	0.06 *	4.25 f	
clk_core_box_1_101/Z (CLKI_O)	0.14 +	4.40 r	
tx_ll/ct_arb/ct_man/ct_ay_rg_43_4/E (D_F_LPH0002_LPC_E)	0.01 *	4.41 r	
clock reconvergence pessimism	0.11	4.52	
clock uncertainty	-0.10	4.42	
library setup time	-0.23	4.19	
data required time		4.19	
data required time		4.19	
data arrival time		-4.17	
slack (MET)		0.01	

The timing report is identical to what we had before CRPR was turned on, with one important exception. Primetime has looked at the cells and nets which are common between the data path and the clock path, calculated the difference between their min and max times, and used the total as an adjust to the clock path. This adjustment shows up in a new line called "clock reconvergence pessimism."

With this adjustment, our setup check is now passing! The hold and clock gating tests pass now also with +30ps and +60ps of slack respectively.

Because it noticeably increases runtime and memory usage, the CRPR algorithm is turned off by default. One option for reducing the impact on runtime and memory usage is to allow some amount of clock reconvergence pessimism to remain in the analysis. The variable timing_crpr_threshold_ps specifies the pessimism removal threshold. Its default value is 20ps which allows 20ps of reconvergence pessimism to remain in the analysis.

8.0 How Primetime's On-Chip Variation Analysis compares to Einstimer's linear combination of delays (LCD)

Users of IBM's Einstimer static timing analysis tool have been doing on-chip variation analysis for years. In Einstimer the process is called "linear combination of delays" or LCD mode. The concepts are the same. Every point has both a min (called early) and a max (called late) time. A setup check tests the late data arrival time against the early clock arrival time. A hold check tests the early data against the late clock. However, Einstimer is different in the way that those early and late arrival times are calculated.

In Primetime, when you specify an operating condition, you are specifying the temperature, voltage, and process point that the cells are going to be modeled at. In Einstimer, you set the temperature and voltage for the analysis that you want to do, but you don't specify a process point. Einstimer is going to use both the best and worst process points in its calculations. Every path in the design has both a best case delay and a worst case delay for the specified temperature and voltage. However, these delays represent the variation of the entire manufacturing process,

not the variation found on a single chip. You then tell Einstimer what timing mode you would like to run in. Best case mode is typically run with high voltage and low temperature. Worst case mode is typically run with low voltage and high temperature. LCD mode is what we really want to do, and it is typically run twice. First it is run with low voltage and high temperature to do our slow chip analysis. Then it is re-run with high voltage and low temperature to do our fast chip analysis.

Because the best case delay and worst case delay that are associated with the paths in the design represent the entire process instead of a single chip, they are not directly used against each other. Instead, they are combined to come up with the early and late times that are used for the setup, hold, and other timing checks. The differences between best, worst, early, and late arrival times are a frequent source of confusion, so it is worth repeating.

- ➤ Best/Worst: Represent variation of entire process, not timed against each other, defined at a specific voltage and temperature.
- Early/Late: Represent the variation of on a single chip, are timed against each other, calculated from the best case and worst case values.

The early and late arrival times are calculated from the best case and worst case numbers using a set of scaling factors. For a slow chip analysis the factors may look like this:

```
Best Nom Worst
Early 0.10 0.00 0.90
Late 0.00 0.00 1.00
```

These factors tell Einstimer that the early arrival times are calculated by adding together the best case time multiplied by 0.10 and the worst case time multiplied by 0.90. The late arrival times are simply the worst case times. In practice the factor that is multiplied against the nominal case number is always zero.

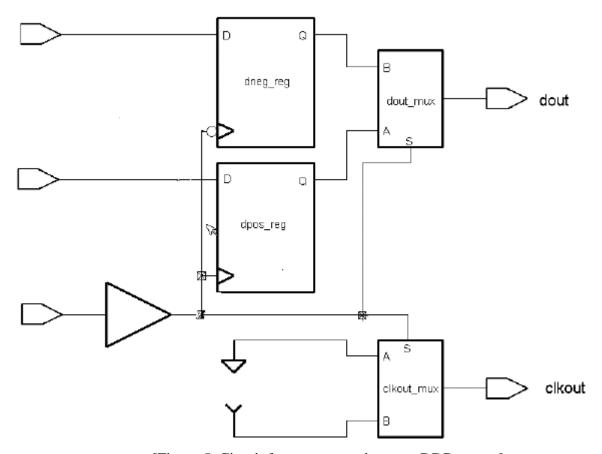
Factors for a fast chip analysis may look like this:

	Best	Nom	Worst
Early	1.00	0.00	0.00
Late	0.90	0.00	0.10

As you would expect, Einstimer has a capability similar to Primetime's CRPR. The name of the function and its abbreviation are also similar. In Einstimer it is called "common path pessimism removal" or CPPR.

9.0My head hurts, my FETs stink

The SPI-4 IP core that we've been using for these examples includes a source synchronous DDR output that serves to illustrate another consideration when running on-chip variation. Paul Zimmer and Andrew Cheng presented a paper [1] at San Jose SNUG this year detailing how to set up timing for this type of an interface. The basic circuit looks like this:



[Figure 5. Circuit for source synchronous DDR output]

This circuit looks like a perfect candidate for CRPR. Except for the final mux and the IO driver, the clock and data paths are entirely common. Our check for the duty cycle on the clock output should be even better. Obviously, a rising edge going from the reference clock input to clkout is going to go through all the same cells as a falling edge. We would expect to receive CRPR credit for the entire path. The OCV effect will be zero.

However, this is somewhat optimistic. While a rising and falling edge will run through all of the same cells and nets, the timing is controlled by different FETs within each cell. The PFETs and NFETs within a cell are not necessarily identical. In essence, there can be some "cross-cell variation." Just because a rising edge through a cell is at worst case, does not mean a falling edge will also be at worst case. Therefore allowing the full CRPR credit is really not accurate.

Primetime does not model these "cross-cell variations" at all. Even if it wanted to, the proper information does not exist in the libraries for this type of analysis to be done. What Primetime does offer is a simple on/off switch.

```
set timing_clock_reconvergence_pessimism normal
set timing clock reconvergence pessimism same transition
```

When the timing_clock_reconvergence_pessimism variable is set to normal (the default setting), Primetime conveniently ignores the potential differences between FETs within a cell, and you are given the entire CRPR credit. When the variable is set to same_transition, Primetime assumes there is no correlation between the FETs, and you get zero CRPR credit in cases where opposite edges through a cell are being timed against each other. This assumption is overly pessimistic and can cause many false failures on tests that include opposite edges. Examples are:

- 1. Paths between negedge and posedge registers.
- 2. Duty cycle checks.
- 3. Clock gating checks and other circuits in clock generation logic.

The static timing engineer must choose (with the library vendor's guidance) between being optimistic, being pessimistic, or writing a bunch of Tcl to manually do the appropriate tests. Einstimer, by the way, always gives you zero credit for opposite edge transitions. (In other words, there is no way to be optimistic when running Einstimer.)

10.0 How OCV Analysis improves silicon performance

Although at first it appears that using on-chip variation analysis steals a bunch of performance from you, I don't think this is necessarily the case. While many ASIC vendors do not require you to run OCV analysis, this does not mean that they have figured out how to build chips with zero variation. If the vendor does not have a manufacturing test that can catch the failures, or if they are not willing to accept the resulting yield loss, they must still account for on-chip variations during static timing analysis. It may be done through padding the setup and hold margins of the flops, requiring extra set_clock_uncertainty even after the clocks are placed and routed, or requiring XXps of positive slack for timing signoff. Any of these methods effectively penalize ALL of the paths in your design. In the setup example above, if the vendor wanted us to increase the clock uncertainy to 200ps instead of running OCV we would still have a failing path. Instead of a tape-out on Friday, we would be working the weekend.

By running on-chip variation analysis, and more specifically the CRPR algorithm, we are able to stuff an extra hundred picoseconds of logic into paths that are contained in a common branch of the clock tree. By modeling the on-chip variation effect more accurately, we are able to get more performance out of the design.

11.0 Conclusions and Recommendations

Most static timing analysis done today does not include on-chip variation analysis. In fact, I know of only two ASIC vendors who require this type of analysis. However, as clock frequencies continue to increase and process geometries continue to decrease, I believe on-chip variation analysis will become more common.

This paper has shown how OCV analysis is run, what the reports look like in Primetime, and how OCV analysis has the potential to increase the performance that we get from our silicon.

For those who will be running OCV analysis on their next static timing project, I have four suggestions:

- 1. Keep this paper close at hand.
- 2. Turn on on-chip variation mode as soon as you have a real clock tree in the design, perhaps even before. The last week before tape-out is NOT the time to find out that you have several hundred failing paths.
- 3. Don't forget to turn on CRPR.
- 4. Send me an e-mail if you need any help.

With these suggestions, I hope you can avoid "Wasting away again in static-timing-ville."

12.0 References

[1] A. Cheng and P. Zimmer, "Working with DDRs in PrimeTime", SNUG San Jose 2002

[] There is also a lot of good information in the PrimeTime user's manual

13.0 Appendix A – Tcl code for timing constraints

```
# Load library
set search_path ". /techlibs/$LIBRARY/$VERSION/synthesis/synopsys ./sv"
set SYN_LIB {$LIBRARY}
set link_path "* $LIBRARY.db"
# Load design
read_verilog sle_spi4_tx_block.v
link_design sle_spi4_tx_block
current_design sle_spi4_tx_block
# Set environment
set_wire_load_model -library $LIBRARY -name $WIRELOAD_MODEL
set_wire_load_mode top
set auto_wire_load_selection {false}
set_operating_conditions -analysis_type bc_wc
# Get parasitics
source sle_spi4_tx_block.cap.tcl
source sle_spi4_tx_block.rc.tcl
# Create Clocks
set core_freq 266
create_clock -period [expr 1000.0 / $core_freq] -name clk_core [get_ports clk_core]
set_clock_uncertainty 0.10 clk_core
set_propagated_clock clk_core
create_clock -period 10.0 -name xi_tsclk [get_ports xi_tsclk]
set_clock_uncertainty 0.10 xi_tsclk
set_propagated_clock xi_tsclk
create_clock -period 2.5 -name xi_xtalclk [get_ports xi_xtalclk]
set_clock_uncertainty 0.10 xi_xtalclk
set_propagated_clock xi_xtalclk
create_generated_clock -name clk_200 -source [get_ports xi_xtalclk] -divide_by 2 [get_pins
clk_rst_400/clk_2nd_divby2_reg/L2]
set_propagated_clock clk_200
# clk_core is asynch to the other clocks
set_false_path -from clk_core -to [remove_from_collection [all_clocks] [get_clocks "clk_core"]]
set_false_path -from [remove_from_collection [all_clocks] [get_clocks "clk_core"]] -to clk_core
# Inputs and Outputs are mostly clk_core
set_input_delay 1.0 -clock clk_core [remove_from_collection [all_inputs] [get_ports "clk_core
xi_tsclk xi_xtalclk"]]
set_output_delay [expr 1000.0 / $core_freq - 1.0] -clock clk_core [remove_from_collection
[all_outputs] [get_ports "xo_tdclk xo_tdat* xo_tctl"]]
group_path -name outputs -to [remove_from_collection [all_outputs] [get_ports "xo_tdclk xo_tdat*
xo_tctl"]]
# These are the exceptions
set_input_delay 1.0 -clock xi_tsclk [get_ports xi_tstat*]
# By default, outputs are clk_core. This bus, however is source synchronous DDR
# We will time it with two virtual clocks as described by Paul Zimmer and Andrew Cheng's
# SNUG San Jose 2002 paper
source setup_ddr_out_timing.tcl
_setup_ddr_out_timing [list xo_tdat* xo_tctl] xo_tdclk xi_xtalclk 0.280 0.280
# Ready to generate reports
```

14.0 Appendix B – Tcl code for DDR output timing constraints

```
# Copyright 2002 by Silicon Logic Engineering. All rights reserved
# File name
             : setup_ddr_out_timing.tcl
# Author
             : Matt Weber
# Revision
             : $Id$
# Description : This Tcl procedure sets up DDR output timing
                constraints similar to the virtual clock approach
                suggested in Paul Zimmer and Andrew Cheng's
#
                SNUG San Jose 2002 paper
               The inputs are as follows:
                _data_output : The name of the data output pin or bus _clk_output : The name of the clock output pin
#
                _source_input : The name of the reference clock
                                which creates the clock and data outputs
                _maxskew0 : Maximum time that data_output can change
#
                                before transition on clk_output
                _maxskew1 : Maximum time that data_output can change
                                after transition on clk_output
               An assumption is made that the data output is
                created by a mux with pin names DO, D1, and SD
          IMPORTANT : The script is not complete yet. To fully
                time these outputs several things need to checked:
                1. Skew between clock and data outputs
#
                2. Duty cycle of clock output
                3. Jitter of data outputs. Since this is DDR, duty
                     cycle on the data outputs looks like jitter.
#
                At this time only the first check is being done.
proc _setup_ddr_out_timing {_data_output _clk_output _source_input _maxskew0 _maxskew1} {
 # Get all the attibutes from the source clock so we can make good copies
 set _source_period [get_attribute [get_clocks $_source_input] period]
 set _source_waveform_junk [split [get_attribute [get_clocks $_source_input] waveform] " {}"]
set _source_waveform "[lindex $_source_waveform_junk 1] [lindex $_source_waveform_junk 2]"
  set _source_setup_uncertainty [get_attribute [get_clocks $_source_input] setup_uncertainty]
  set _source_hold_uncertainty [get_attribute [get_clocks $_source_input] hold_uncertainty]
  # Then get the rising edge latency from source_input to clk_output
  set _path [get_timing_paths -from [get_ports $_source_input] -to [get_ports $_clk_output] -
delay max_rise]
  set _rise_latency [get_attribute $_path arrival]
  # Then the falling edge latency from source_input to clk_output
 set _path [get_timing_paths -from [get_ports $_source_input] -to [get_ports $_clk_output] -
delay max_fall]
  set _fall_latency [get_attribute $_path arrival]
  # Create a virtual clock to use for comparisions to rising edge of clk_output
  set posclkname [format %s_posclkout $_clk_output]
 create_clock -period $_source_period -waveform $_source_waveform -name $posclkname
  set_clock_latency $_rise_latency -rise -source [get_clocks $posclkname]
  set_clock_latency $_fall_latency -fall -source [get_clocks $posclkname]
 set_clock_uncertainty -setup $_source_setup_uncertainty $posclkname
  set_clock_uncertainty -hold $_source_hold_uncertainty $posclkname
  # Create another virtual clock to use for comparisions to falling edge of clk_output
  set negclkname [format %s_negclkout $_clk_output]
 create_clock -period $_source_period -waveform $_source_waveform -name $negclkname
 set_clock_latency $_rise_latency -rise -source [get_clocks $negclkname]
  set_clock_latency $_fall_latency -fall -source [get_clocks $negclkname]
  set_clock_uncertainty -setup $_source_setup_uncertainty $negclkname
 set_clock_uncertainty -hold $_source_hold_uncertainty $negclkname
  # Set output delays for data_output.
  # _maxskew0, the maximum amount of time that the data output can change before the clock output
       is really a hold test
 set_output_delay $_maxskew0 -clock $posclkname [get_ports $_data_output] -min
 set_output_delay $_maxskew0 -clock $negclkname [get_ports $_data_output] -min -add_delay -
clock_fall
```

```
# _maxskew1, the maximum amount of time that the data output can change after the clock output
        is really a setup test
  set_output_delay [expr $_source_period/2.0 - $_maxskew1] -clock $posclkname [get_ports
$_data_output] -max -add_delay
  set_output_delay [expr $_source_period/2.0 - $_maxskew1] -clock $negclkname [get_ports
$_data_output] -max -add_delay -clock_fall
  # For DDR outputs built with posedge/negedge regs followed by a mux, assume data from
  # the DO side of the mux gets captured by poschkout virtual clock, and data from the
      D1 side gets captured by the negclkout virtual clock
  # The loops here seem to be pretty slow. Should look for a better way. Or hardcode the
    relavant gate names so we don't have to do this search for them.
  foreach_in_collection temp_output [get_ports $_data_output] {
    foreach_in_collection temp_path [get_timing_paths -to [get_ports $temp_output] -delay
max_rise] {
      foreach_in_collection temp_point [get_attribute $temp_path points] {
          set object [get_attribute $temp_point object]
          set point_name [get_attribute $object full_name]
if {[string match */D0 $point_name] } {
            echo "_setup_ddr_out_timing is setting false_path from $point_name to virtual clock
$negclkname for setup checks"
            set_false_path -setup -through [get_pins $point_name] -to [get_clocks $negclkname]
           if {[string match */D1 $point_name] } {
            echo "_setup_ddr_out_timing is setting false_path from $point_name to virtual clock
$posclkname for setup checks"
            set_false_path -setup -through [get_pins $point_name] -to [get_clocks $posclkname]
    }
}
```